

<b>Notice of References Cited</b>	Application/Control No. 10/590,549	Applicant(s)/Patent Under Reexamination OHNO ET AL.	
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**U.S. PATENT DOCUMENTS**

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**FOREIGN PATENT DOCUMENTS**

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*	N	JP 03-034270	02-1991	JP	Iwahara et al	H01M 10/40
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